Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/778,961	YAN ET AL.	
Examiner	Art Unit	
Tekchand Saidha	1652	

SEARCHED				
Class	Subclass	Date	Examiner	
435	198			
	252.3			
	320.1			
536	23.2	5/31/2005	TEK	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	198		·
	252.3		
	320.1	5/31/2005	TEK
536	23,2	510410005	
SEQID	Nos. 1-3	5/31/2005	Tek

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
SEQ ID Nos. 1-3 (search enclosed) (SEQ ID NO: 3 Was Learch in fragments only)	5/31/2005	TEK	
Selected STN and West searches are enclosed.	5/31/2005	TEK	
Inventor name search	5/31/2005	TEK	